


<b>Search Notes</b>  	<b>Application/Control No.</b>  10581481	<b>Applicant(s)/Patent Under Reexamination</b>  IKEDA ET AL.
	<b>Examiner</b>  YUK CHOW	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	107	9/28/2009	yc
359	296	9/28/2009	yc
313	498	9/28/2009	yc

SEARCH NOTES		
Search Notes	Date	Examiner
EAST:electrophoretic particles, partition wall, recess portion.	9/28/2009	yc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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